

BUK9Y11-30B N-channel TrenchMOS logic level FET Rev. 01 — 30 August 2007

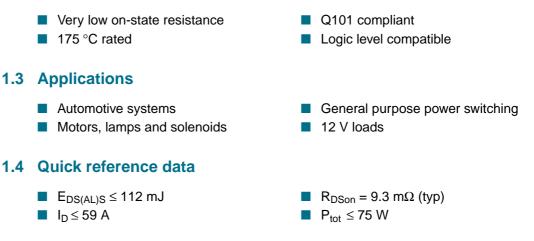
Product data sheet

Product profile 1.

1.1 General description

N-channel enhancement mode power Field-Effect Transistor (FET) in a plastic package using NXP High-Performance Automotive (HPA) TrenchMOS technology.

1.2 Features



Pinning information 2.

Table 1.	Pinning
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Pin	Description	Simplified outline	Symbol
1, 2, 3	source (S)		-
4	gate (G)	mb	
mb	mounting base; connected to drain (D)		G mb/798 S1 S2 S3
		SOT669 (LFPAK)	



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3. Ordering information

Table 2. Ordering information				
Type number Packag				
	Name	Description	Version	
BUK9Y11-30B	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669	

4. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
V _{DS}	drain-source voltage		-	30	V
V _{DGR}	drain-gate voltage (DC)	$R_{GS} = 20 \text{ k}\Omega$	-	30	V
V _{GS}	gate-source voltage		-	±15	V
I _D	drain current	T_{mb} = 25 °C; V_{GS} = 5 V; see <u>Figure 2</u> and <u>3</u>	-	59	А
		T_{mb} = 100 °C; V_{GS} = 5 V; see <u>Figure 2</u>	-	42	А
I _{DM}	peak drain current	T_{mb} = 25 °C; pulsed; $t_p \le 10 \ \mu s$; see Figure 3	-	239	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>	-	75	W
T _{stg}	storage temperature		-55	+175	°C
Tj	junction temperature		-55	+175	°C
Source-d	rain diode				
I _{DR}	reverse drain current	T _{mb} = 25 °C	-	59	А
I _{DRM}	peak reverse drain current	T_{mb} = 25 °C; pulsed; $t_p \leq$ 10 μs	-	239	А
Avalanch	e ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	unclamped inductive load; I _D = 59 A; V _{DS} \leq 30 V; V _{GS} = 5 V; R _{GS} = 50 Ω ; starting at T _j = 25 °C	-	112	mJ
E _{DS(AL)R}	repetitive drain-source avalanche energy		-	<u>[1]</u>	-

[1] Conditions:

a) Maximum value not quoted. Repetitive rating defined in Figure 16.

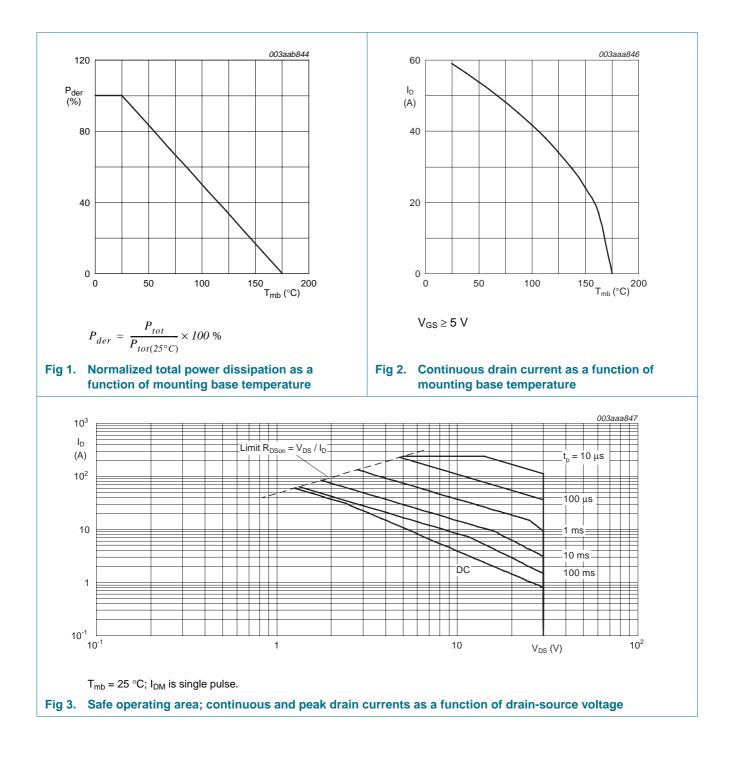
b) Single-pulse avalanche rating limited by $T_{j(max)}$ of 175 $^\circ\text{C}.$

c) Repetitive avalanche rating limited by an average junction temperature of 170 $^\circ\text{C}.$

d) Refer to application note AN10273 for further information.

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5. Thermal characteristics

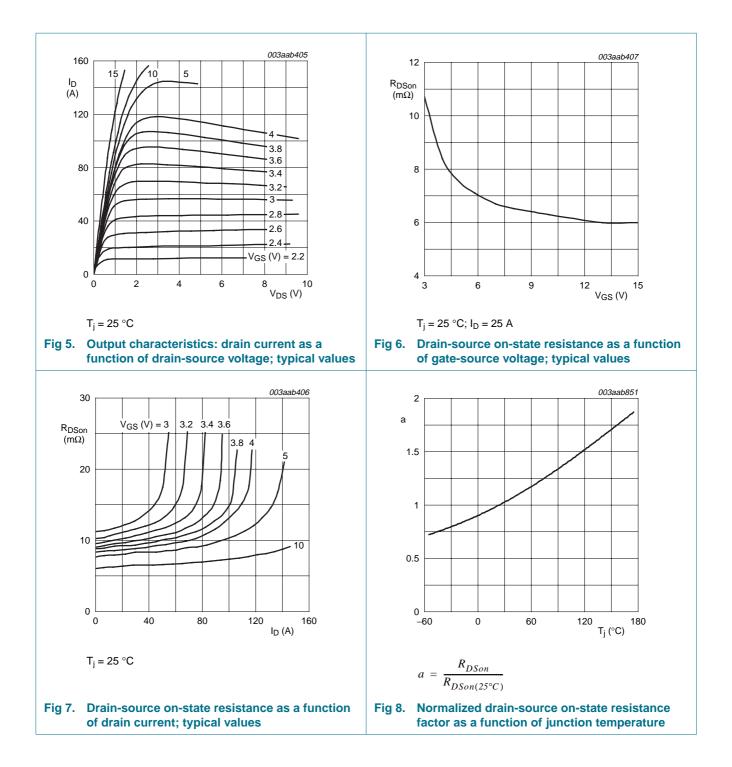
R _{th(j-mb)} t	thermal resistance from junction to mounting base -			_	
		-	-	2	K/W
10 👝			003a	122848	
Z _{th(j-mb)}				++++	
(K/W)					
δ	i = 0.5				
1					
0	0.2				
- 0.	<u>).1</u>				
0.	.05			to	
10 ⁻¹		P	δ=	T	
				I E	
		\rightarrow t_{o}			
	single shot		- T		
10 ⁻²					
10 ⁻⁶	10 ⁻⁵ 10 ⁻⁴ 10 ⁻³ 10 ⁻²	10 ⁻¹	t _p (s)	1	

Table 4: Thermal characteristics

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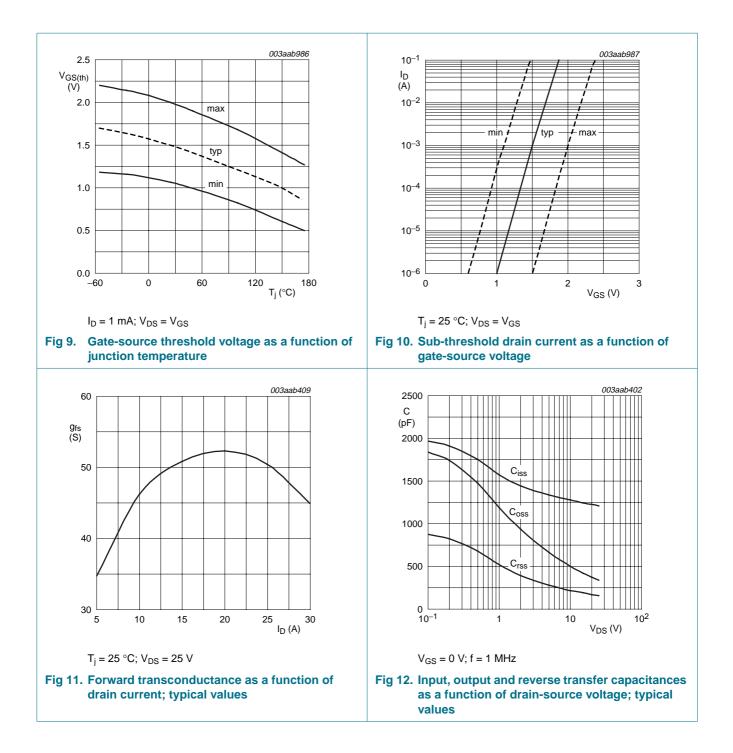
6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	30	-	-	V
		T _j = −55 °C	27	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; \text{ see } \frac{\text{Figure 9}}{\text{Figure 9}} \text{ and } \frac{10}{10}$				
		T _j = 25 °C	1.1	1.5	2	V
		T _j = 175 °C	0.5	-	-	V
		T _j = −55 °C	-	-	2.3	V
DSS	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}$				
		T _j = 25 °C	-	0.02	1	μA
		T _j = 175 °C	-	-	500	μA
GSS	gate leakage current	$V_{GS} = \pm 15 \text{ V}; V_{DS} = 0 \text{ V}$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; \text{ see } \frac{\text{Figure 6}}{\text{Figure 6}} \text{ and } \frac{8}{2}$				
		T _j = 25 °C	-	9.3	11	mΩ
		T _j = 175 °C	-	-	21	mΩ
		V_{GS} = 4.5 V; I _D = 25 A	-	-	12	mΩ
		V_{GS} = 10 V; I _D = 25 A	-	8.1	9	mΩ
Dynamic o	haracteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 5 \text{ V};$	-	16.5	-	nC
Q _{GS}	gate-source charge	see Figure 14	-	3.3	-	nC
ସ୍ _{GD}	gate-drain charge		-	5.4	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$	-	1211	1614	pF
C _{oss}	output capacitance	see Figure 12	-	341	409	pF
C _{rss}	reverse transfer capacitance		-	160	220	pF
d(on)	turn-on delay time	$V_{DS} = 25 \text{ V}; \text{ R}_{L} = 2.5 \Omega;$	-	14	-	ns
r	rise time	V_{GS} = 5 V; R_{G} = 10 Ω	-	33	-	ns
d(off)	turn-off delay time		-	62	-	ns
f	fall time		-	42	-	ns
Source-dr	ain diode					
/ _{SD}	source-drain voltage	$I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; \text{ see } \frac{\text{Figure } 15}{100000000000000000000000000000000000$	-	0.85	1.2	V
rr	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s};$	-	47	-	ns
ე _r	recovered charge	V _{GS} = 0 V; V _R = 30 V	-	20	-	nC



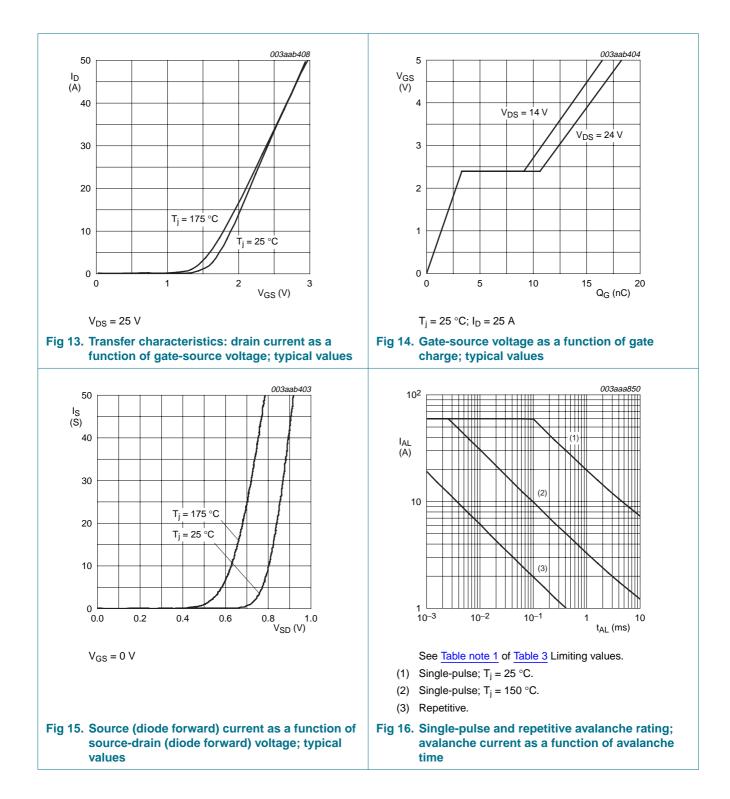
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7. Package outline

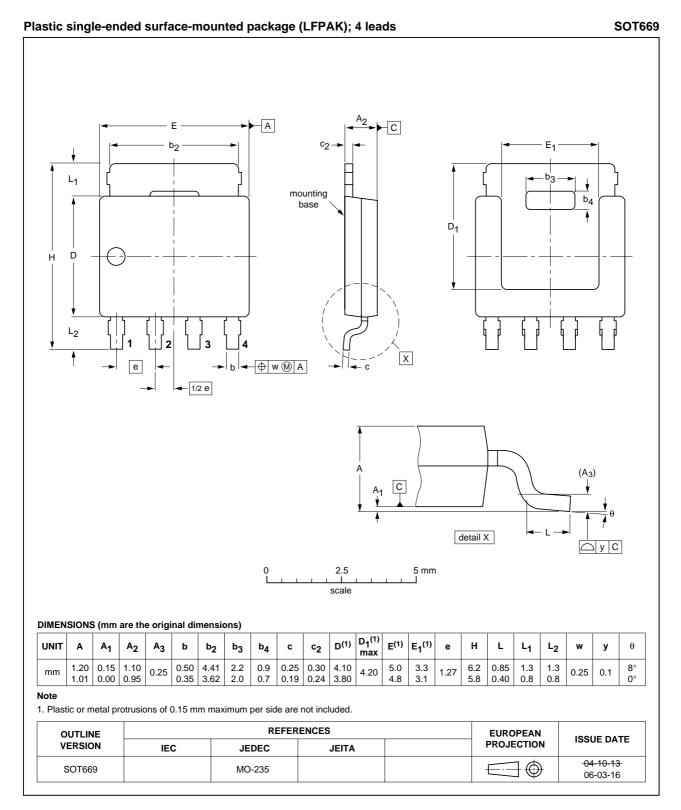


Fig 17. Package outline SOT669 (LFPAK)

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8. Revision history

Table 6. Revision history					
Document ID		Release date	Data sheet status	Change notice	Supersedes
BUK9Y11-30E	3_1	20070830	Product data sheet	-	-

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9. Legal information

9.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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